



File No. 4463
U.S. Pat. Appln. Ser. No. 09/762,863

B/A
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT: Euler et al. GROUP: 2877
SERIAL NO: 09/762,863 EXAMINER: Lee, A.
FILED: May 2, 2001
FOR: THIN FILM STRAIN SENSORS BASED ON
INTER-FEROMETRIC OPTICAL MEASUREMENTS

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

RULE 312 AMENDMENT

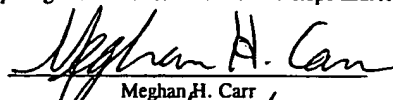
IN THE SPECIFICATION:

On page 1, line 3, please insert the following paragraph:

This application, which is a National Stage of International Application No. PCT/US99/19601, filed on August 25, 1999, claims priority to U.S. Provisional Application No. 60/097,989, filed on August 26, 1998.

OK to enter
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